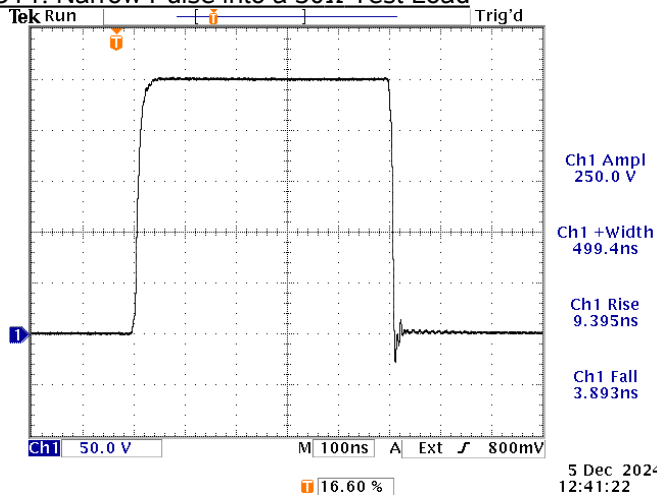




PERFORMANCE CHECKSHEET

Model: AVR-3-PW-TEK3-B-P
Type: High-Speed Current Probe Test System
S.N.: 11234 (re-calibration)
Date: December 5, 2024

OUT1: Narrow Pulse into a 50Ω Test Load



Output of "OUT1" connector, terminated into an external 50 Ohm test load. Viewed with TDS3052 scope. 50V/div, 100 ns/div. 10 Hz.

a) Output Signal Amplitude (to 50Ω):
OUT1: 0 to +250V (+5A max.)
OUT2: 0 to +50 V (+1A max.)

b) Pulse Width:
OUT1: 250 ns to 250 us
OUT1: 50 ns to 200 ns

c) Rise Time (20-80%):
OUT1: < 10 ns
OUT2: < 0.5 ns

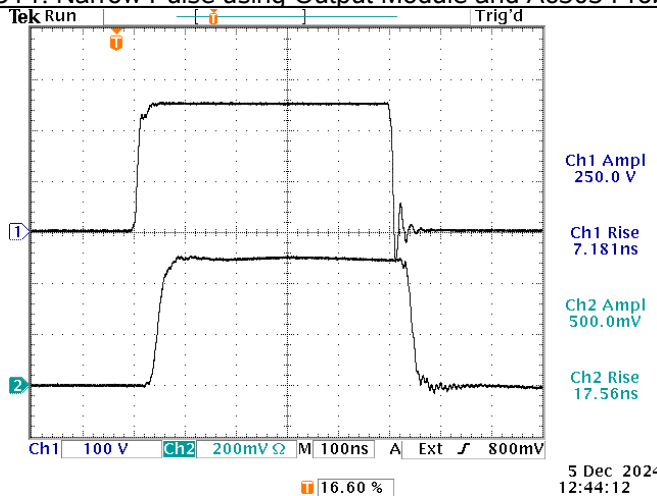
d) Fall Time (80-20%):
OUT1: < 10 ns
OUT2: < 0.5 ns

e) PRF: 0 - 10 kHz

f) Jitter, Stability: OK

g) Prime Power: 100-240V AC, 50-60 Hz.

OUT1: Narrow Pulse using Output Module and A6303 Probe

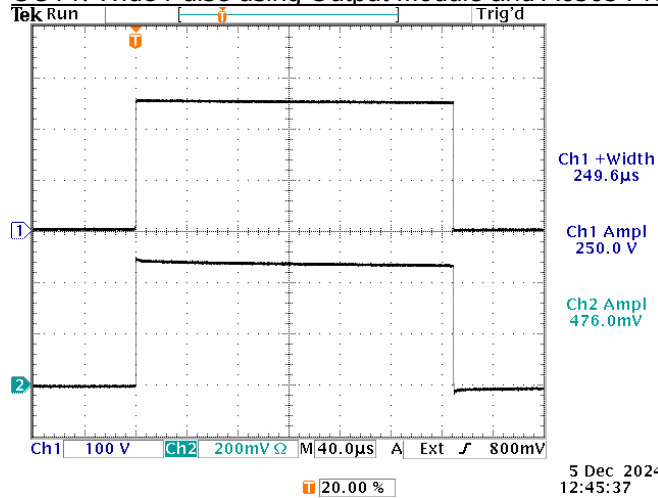


Top: +250V voltage waveform (measured at clamping cable).
Bottom: Output of A6303 probe, viewed with TDS3052 scope.
The A6303 probe is clamped to the shorting cable.

The current probes used in obtaining these waveforms are not calibrated, and are for examples purposes only. The amplitudes from the probes may be out of tolerance.

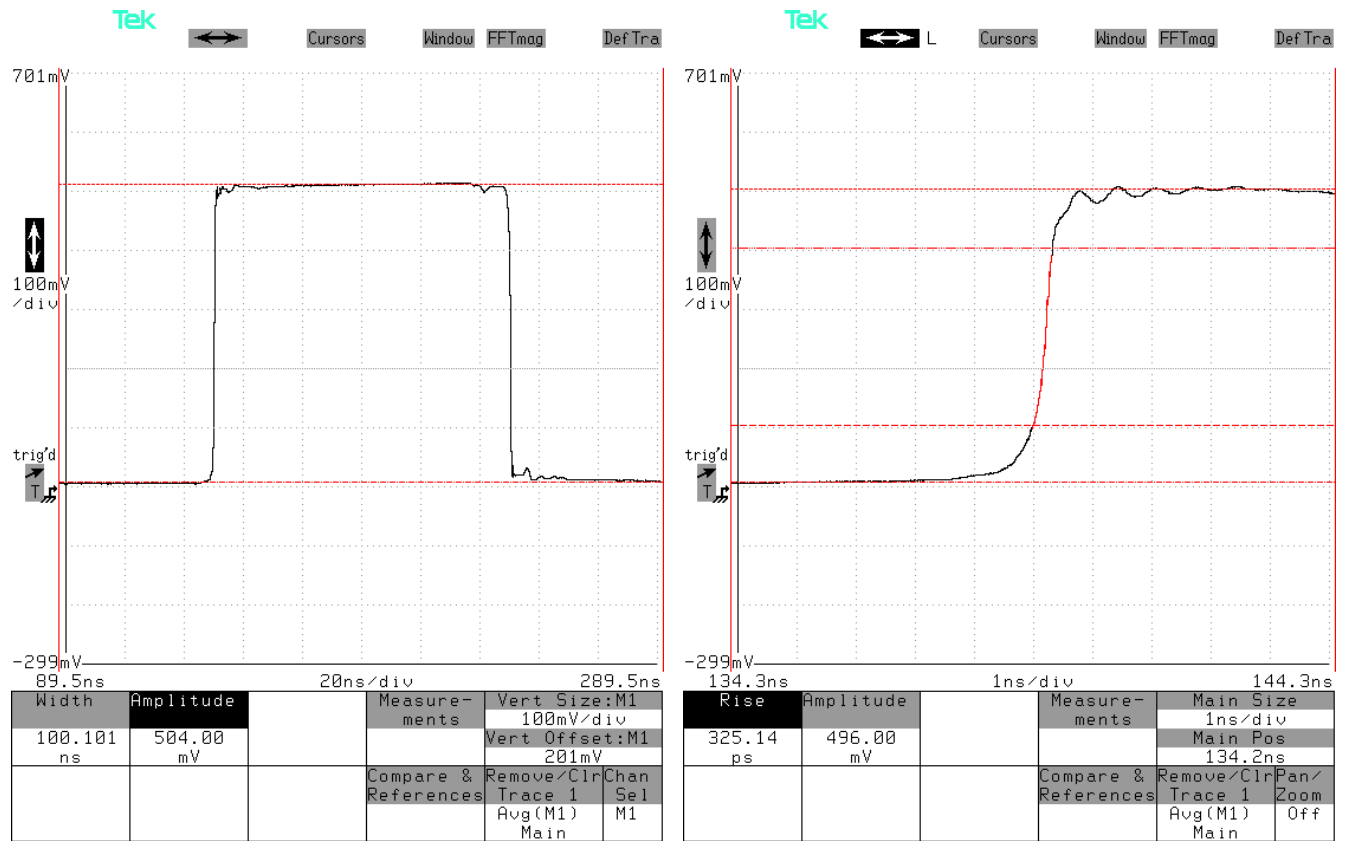
All rise/fall references levels: 20%, 80%.

OUT1: Wide Pulse using Output Module and A6303 Probe



Top: +250V voltage waveform (measured at clamping cable). Bottom: Output of A6303 probe, viewed with TDS3052 scope. The A6303 probe is clamped to the shorting cable.

OUT2: 100 ns Pulse into a 50Ω Test Load



10 V/div (100 mV/div x 40 dB), 20 ns/div. "OUT2" into a sampling oscilloscope.

Scaled at 1 ns / div to show rising edge.

OUT2: 200 ns Pulse using Output Module and P6042 Probe

